December 2014

# FCH110N65F

## N-Channel SuperFET® II FRFET® MOSFET

### 650 V, 35 A, 110 mΩ

## Features

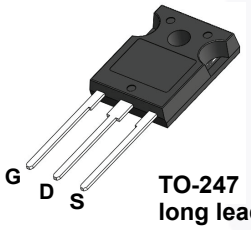
- 700 V @ $T_J$ = 150°C
- Typ. $R_{DS(on)}$ = 96 mΩ (Typ.)
- Ultra Low Gate Charge (Typ. $Q_g$ = 98 nC)
- Low Effective Output Capacitance (Typ. $C_{oss(eff.)}$ = 464 pF)
- 100% Avalanche Tested
- RoHS Compliant

## Applications

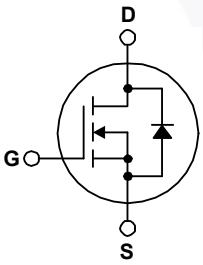
- LCD / LED / PDP TV
- Solar Inverter
- Telecom / Server Power Supplies
- AC - DC Power Supply

## Description

SuperFET® II MOSFET is Fairchild Semiconductor's brand-new high voltage super-junction (SJ) MOSFET family that is utilizing charge balance technology for outstanding low on-resistance and lower gate charge performance. This technology is tailored to minimize conduction loss, provide superior switching performance, dv/dt rate and higher avalanche energy. Consequently, SuperFET II MOSFET is very suitable for the switching power applications such as PFC, server/telecom power, FPD TV power, ATX power and industrial power applications. SuperFET II FRFET® MOSFET's optimized body diode reverse recovery performance can remove additional component and improve system reliability.




**TO-247**
**long leads**




## Absolute Maximum Ratings $T_C$ = 25°C unless otherwise noted.

| Symbol | Parameter | | FCH110N65F_F155 | Unit |
|---|---|---|---|---|
| $V_{DSS}$ | Drain to Source Voltage | | 650 | V |
| $V_{GSS}$ | Gate to Source Voltage | - DC | ±20 | V |
| | | - AC (f > 1 Hz) | ±30 | |
| $I_D$ | Drain Current | - Continuous ($T_C$ = 25°C) | 35 | A |
| | | - Continuous ($T_C$ = 100°C) | 24 | |
| $I_{DM}$ | Drain Current | - Pulsed (Note 1) | 105 | A |
| $E_{AS}$ | Single Pulsed Avalanche Energy | (Note 2) | 809 | mJ |
| $I_{AR}$ | Avalanche Current | (Note 1) | 8 | A |
| $E_{AR}$ | Repetitive Avalanche Energy | (Note 1) | 3.57 | mJ |
| dv/dt | MOSFET dv/dt | | 100 | V/ns |
| | Peak Diode Recovery dv/dt | (Note 3) | 50 | |
| $P_D$ | Power Dissipation | ($T_C$ = 25°C) | 357 | W |
| | | - Derate Above 25°C | 2.86 | W/°C |
| $T_J$, $T_{STG}$ | Operating and Storage Temperature Range | | -55 to +150 | °C |
| $T_L$ | Maximum Lead Temperature for Soldering, 1/8" from Case for 5 Seconds | | 300 | °C |

## Thermal Characteristics

| Symbol | Parameter | FCH110N65F_F155 | Unit |
|---|---|---|---|
| $R_{\theta JC}$ | Thermal Resistance, Junction to Case, Max. | 0.35 | °C/W |
| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient, Max. | 40 | |

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## Package Marking and Ordering Information

| Part Number | Top Mark | Package | Packing Method | Reel Size | Tape Width | Quantity |
|---|---|---|---|---|---|---|
| FCH110N65F_F155 | FCH110N65F | TO-247G03 | Tube | N/A | N/A | 30 units |

## Electrical Characteristics $T_C = 25^oC$ unless otherwise noted.

| Symbol | Parameter | Test Conditions | Min. | Typ. | Max. | Unit |
|---|---|---|---|---|---|---|
| **Off Characteristics** | | | | | | |
| $BV_{DSS}$ | Drain to Source Breakdown Voltage | $V_{GS}$ = 0 V, $I_D$ = 10 mA, $T_J$ = 25°C | 650 | - | - | V |
| | | $V_{GS}$ = 0 V, $I_D$ = 10 mA, $T_J$ = 150°C | 700 | - | - | |
| $\Delta BV_{DSS}$ / $\Delta T_J$ | Breakdown Voltage Temperature Coefficient | $I_D$ = 10 mA, Referenced to 25°C | - | 0.72 | - | V/°C |
| $I_{DSS}$ | Zero Gate Voltage Drain Current | $V_{DS}$ = 650 V, $V_{GS}$ = 0 V | - | - | 10 | μA |
| | | $V_{DS}$ = 520 V, $T_C$ = 125°C | - | 110 | - | |
| $I_{GSS}$ | Gate to Body Leakage Current | $V_{GS}$ = ±20 V, $V_{DS}$ = 0 V | - | - | ±100 | nA |
| **On Characteristics** | | | | | | |
| $V_{GS(th)}$ | Gate Threshold Voltage | $V_{GS}$ = $V_{DS}$, $I_D$ = 3.5 mA | 3 | - | 5 | V |
| $R_{DS(on)}$ | Static Drain to Source On Resistance | $V_{GS}$ = 10 V, $I_D$ = 17.5 A | - | 96 | 110 | mΩ |
| $g_{FS}$ | Forward Transconductance | $V_{DS}$ = 20 V, $I_D$ = 17.5 A | - | 30 | - | S |
| **Dynamic Characteristics** | | | | | | |
| $C_{iss}$ | Input Capacitance | $V_{DS}$ = 100 V, $V_{GS}$ = 0 V, f = 1 MHz | - | 3680 | 4895 | pF |
| $C_{oss}$ | Output Capacitance | | - | 110 | 145 | pF |
| $C_{rss}$ | Reverse Transfer Capacitance | | - | 0.65 | - | pF |
| $C_{oss}$ | Output Capacitance | $V_{DS}$ = 380 V, $V_{GS}$ = 0 V, f = 1 MHz | - | 65 | - | pF |
| $C_{oss(eff.)}$ | Effective Output Capacitance | $V_{DS}$ = 0 V to 400 V, $V_{GS}$ = 0 V | - | 464 | - | pF |
| $Q_{g(tot)}$ | Total Gate Charge at 10V | $V_{DS}$ = 380 V, $I_D$ = 17.5 A, $V_{GS}$ = 10 V (Note 4) | - | 98 | 145 | nC |
| $Q_{gs}$ | Gate to Source Gate Charge | | - | 20 | - | nC |
| $Q_{gd}$ | Gate to Drain “Miller” Charge | | - | 43 | - | nC |
| ESR | Equivalent Series Resistance | f = 1 MHz | - | 0.7 | - | Ω |
| **Switching Characteristics** | | | | | | |
| $t_{d(on)}$ | Turn-On Delay Time | $V_{DD}$ = 380 V, $I_D$ = 17.5 A, $V_{GS}$ = 10 V, $R_g$ = 4.7 Ω (Note 4) | - | 31 | 72 | ns |
| $t_r$ | Turn-On Rise Time | | - | 21 | 52 | ns |
| $t_{d(off)}$ | Turn-Off Delay Time | | - | 89 | 188 | ns |
| $t_f$ | Turn-Off Fall Time | | - | 5.7 | 21 | ns |
| **Drain-Source Diode Characteristics** | | | | | | |
| $I_S$ | Maximum Continuous Drain to Source Diode Forward Current | | - | - | 35 | A |
| $I_{SM}$ | Maximum Pulsed Drain to Source Diode Forward Current | | - | - | 105 | A |
| $V_{SD}$ | Drain to Source Diode Forward Voltage | $V_{GS}$ = 0 V, $I_{SD}$ = 17.5 A | - | - | 1.2 | V |
| $t_{rr}$ | Reverse Recovery Time | $V_{GS}$ = 0 V, $I_{SD}$ = 17.5 A, $dI_F/dt$ = 100 A/μs | - | 133 | - | ns |
| $Q_{rr}$ | Reverse Recovery Charge | | - | 0.67 | - | μC |

**Notes:**

1. Repetitive rating: pulse width limited by maximum junction temperature.
2. $I_{AS}$ = 8 A, $R_G$ = 25 Ω, starting $T_J$ = 25°C.
3. $I_{SD} \le$ 17.5 A, di/dt ≤ 200 A/μs, $V_{DD} \le$ 380 V, starting $T_J$ = 25°C.
4. Essentially independent of operating temperature typical characteristics.

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## Typical Performance Characteristics

**Figure 1. On-Region Characteristics**

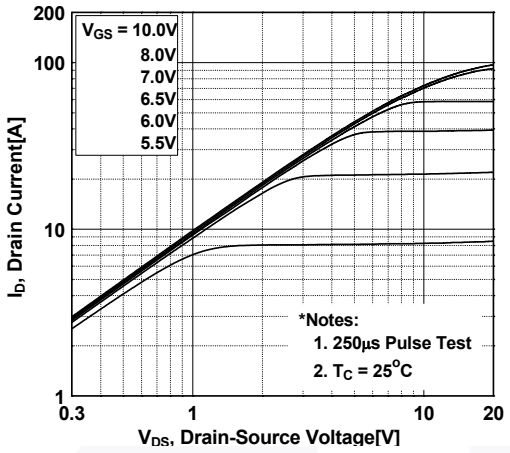



**Figure 2. Transfer Characteristics**

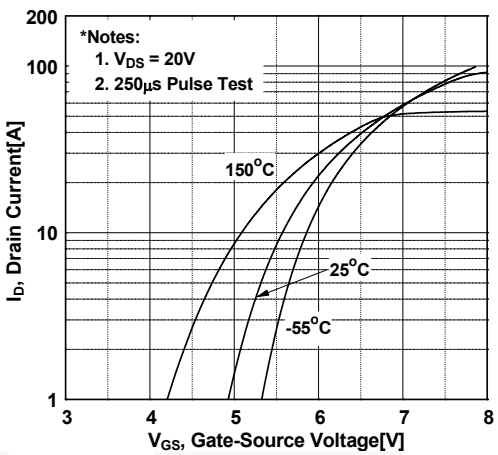



**Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage**

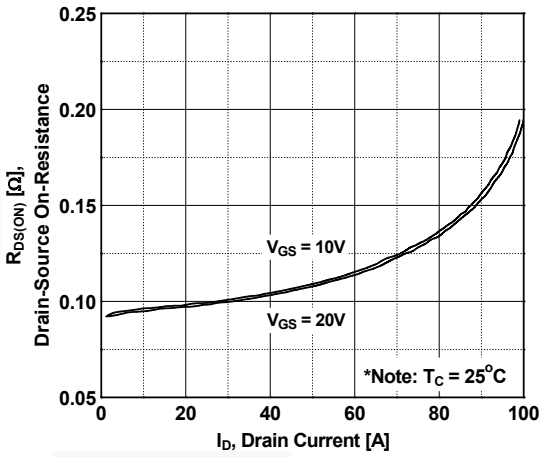



**Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature**

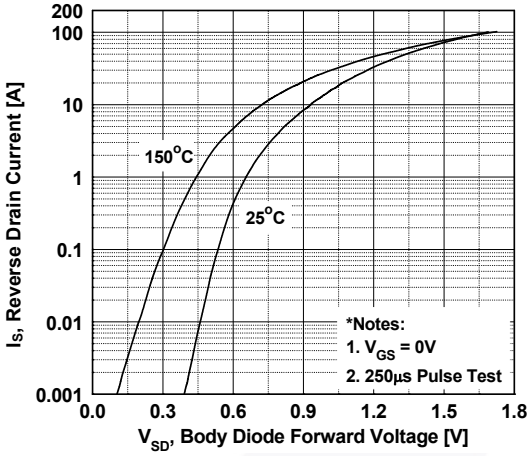



**Figure 5. Capacitance Characteristics**

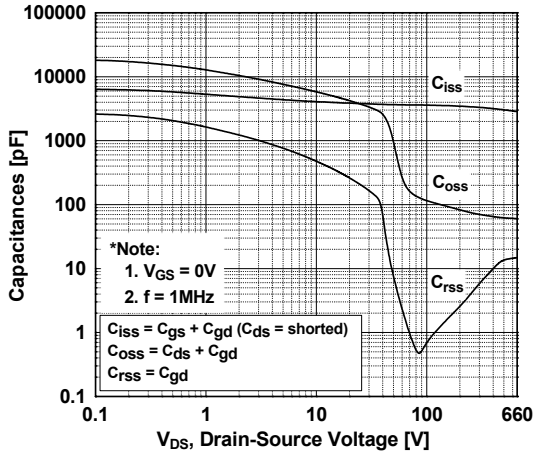
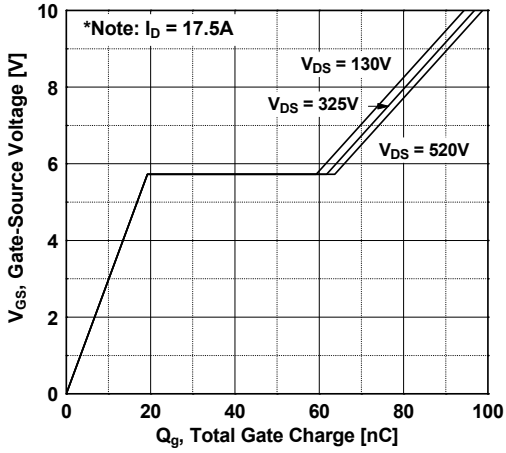



**Figure 6. Gate Charge Characteristics**

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## Typical Performance Characteristics (Continued)

**Figure 7. Breakdown Voltage Variation vs. Temperature**

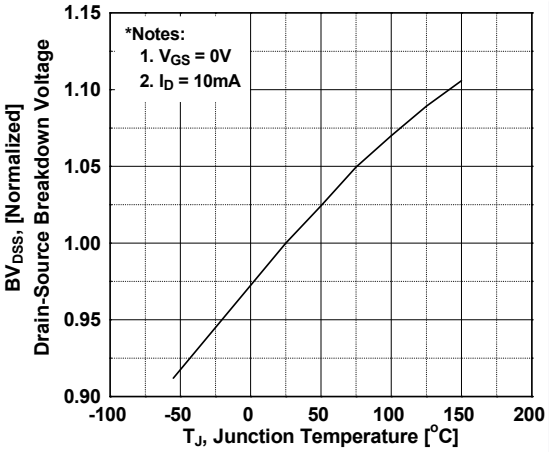



**Figure 8. On-Resistance Variation vs. Temperature**

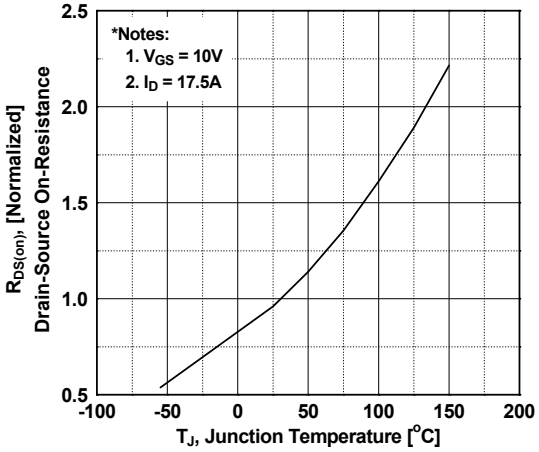



**Figure 9. Maximum Safe Operating Area**

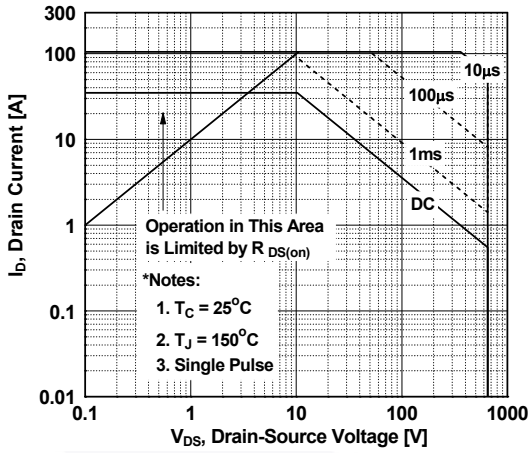



**Figure 10. Maximum Drain Current vs. Case Temperature**

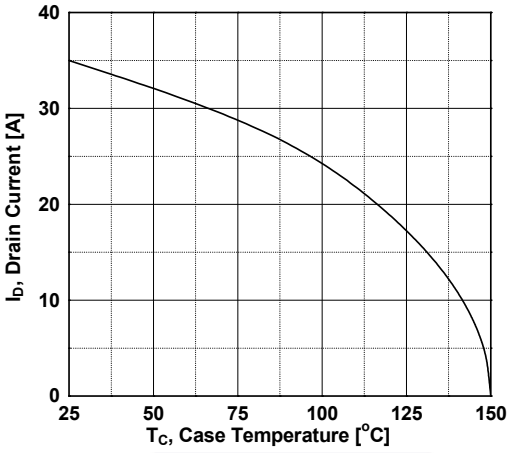
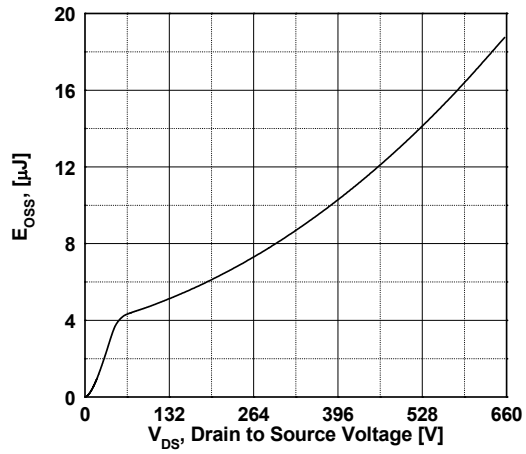
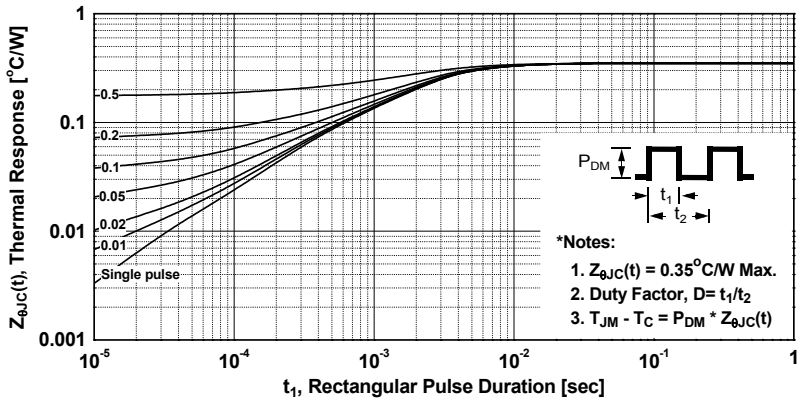



**Figure 11. Eoss vs. Drain to Source Voltage**



## Typical Performance Characteristics (Continued)

**Figure 12. Transient Thermal Response Curve**



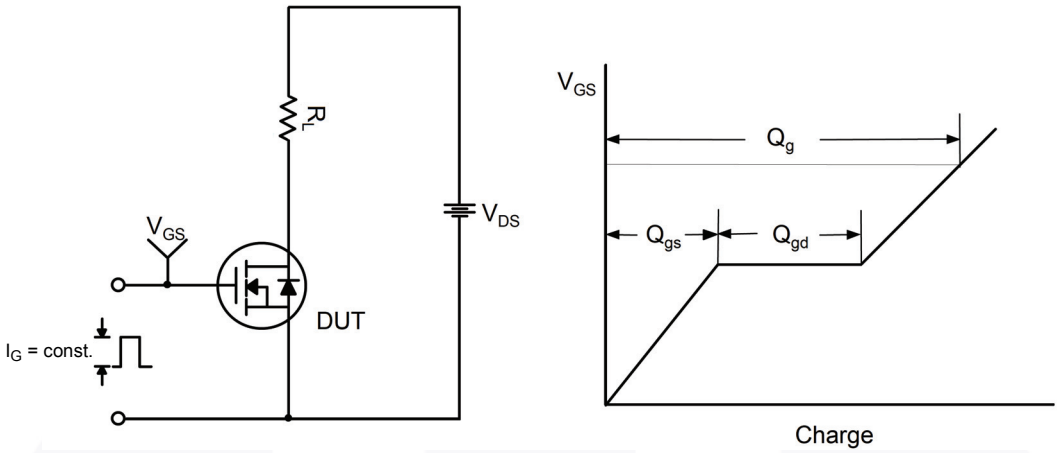



**Figure 13. Gate Charge Test Circuit & Waveform**

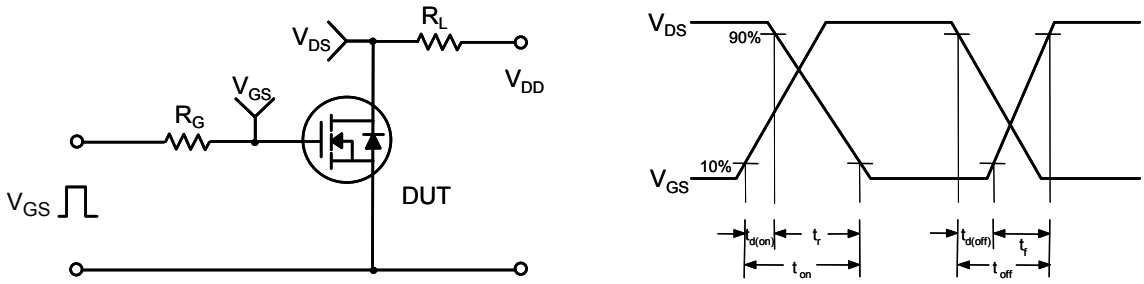



**Figure 14. Resistive Switching Test Circuit & Waveforms**

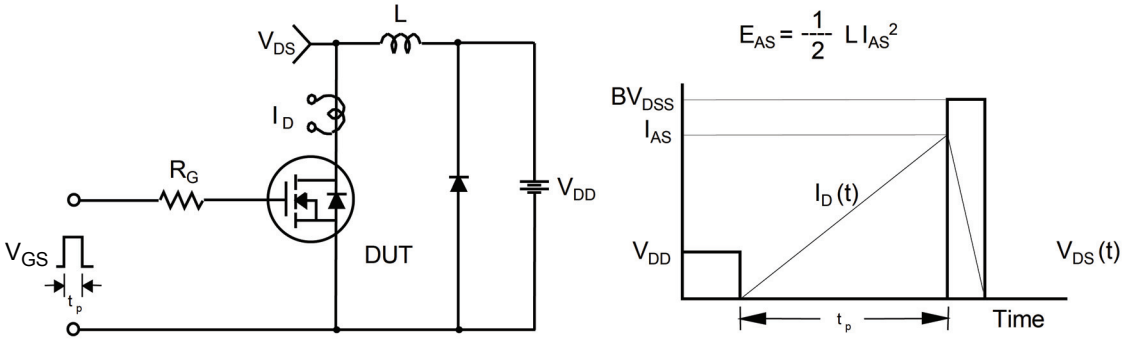



**Figure 15. Unclamped Inductive Switching Test Circuit & Waveforms**

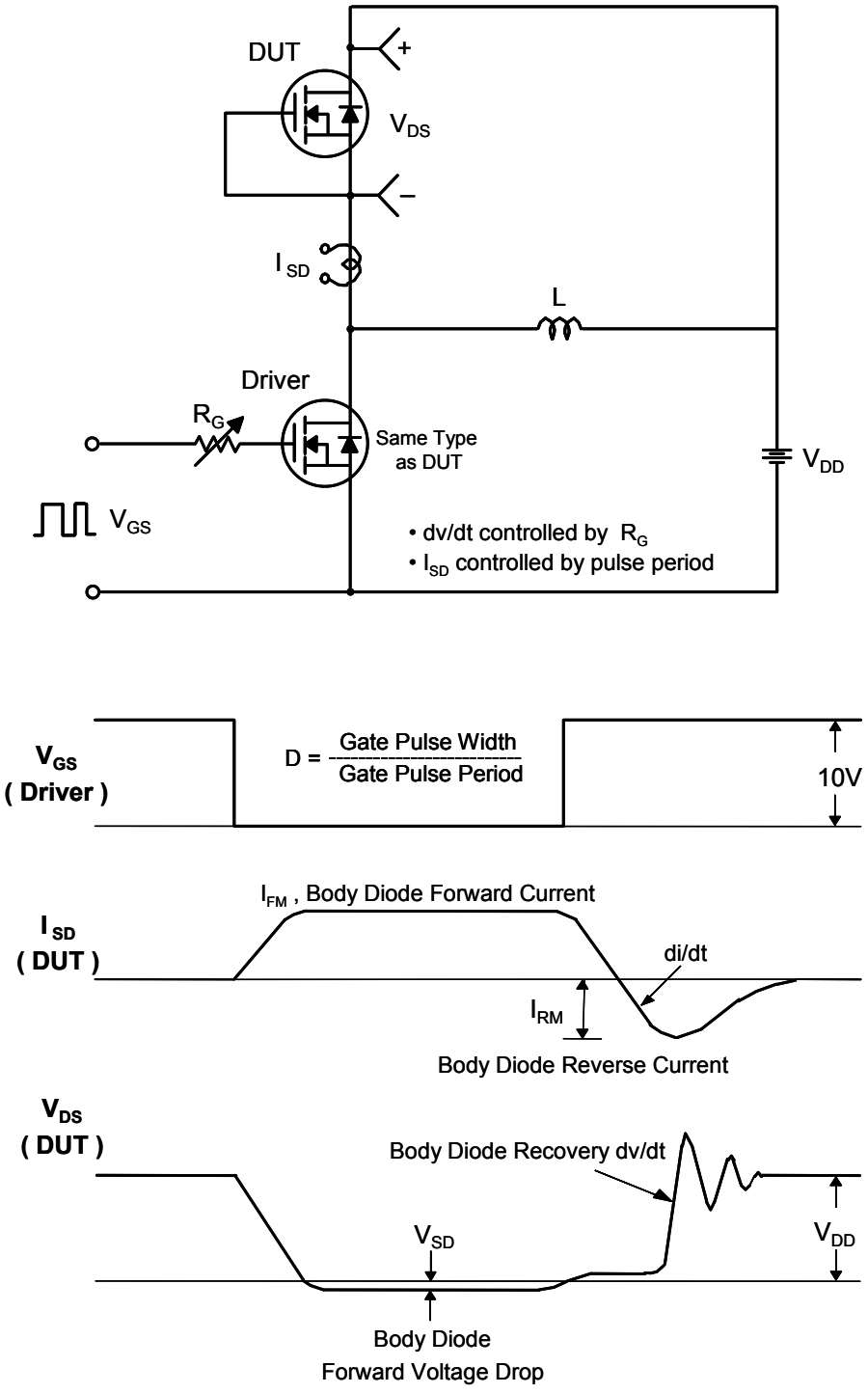



**Figure 16. Peak Diode Recovery dv/dt Test Circuit & Waveforms**

## Mechanical Dimensions

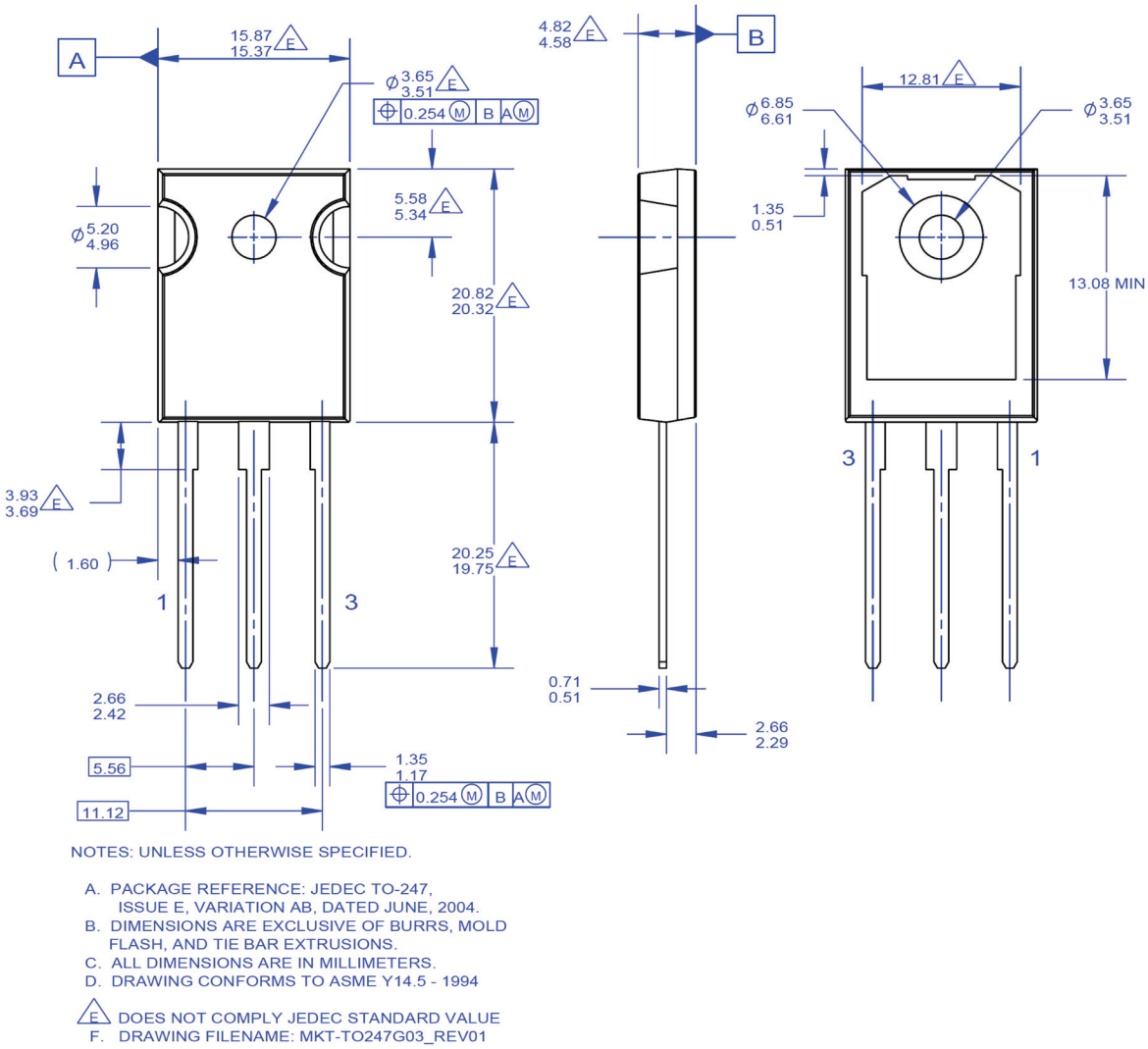



**Figure 17. TO-247, Molded, 3-Lead, Jedec AB Long Leads**

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